

## Registration Form

One-Day Course on

### ***The Atom Probe***

9<sup>th</sup> January, 2012

Last date for registration: 20<sup>th</sup> December 2011

Sir,

I want to attend the one-day workshop on Atom Probe Tomography. Kindly register me. Following are my details:

Name :

Designation :

Organization :

Address :

Email :

Tel. :

Accommodation required: Yes/No

Please send the completed registration form by e-mail to

**Prof. B.S. Murty**

Email: [murty@iitm.ac.in](mailto:murty@iitm.ac.in)

Ph.: 044-22574754

**Dr. Srinivasa R. Bakshi**

Email: [sbakshi@iitm.ac.in](mailto:sbakshi@iitm.ac.in)

Ph.: 044-22574781

Department of Metallurgical and Materials Engineering  
Indian Institute of Technology Madras  
Chennai, India – 600036

## ONE-DAY WORKSHOP ON ATOM PROBE TOMOGRAPHY

*Organized by*

Department of Metallurgical and Materials  
Engineering, IIT Madras

*and*

Combinatorial Sciences and Materials Informatics  
Collaboratory (CoSMIC), Iowa State University, USA

*In association with*

Defence Metallurgical Research Laboratory,  
Hyderabad

Convenor: **Prof. B.S. Murty**

Co-Convenor: **Dr. Srinivasa Rao Bakshi**

Date: **9<sup>th</sup> January, 2012**

Venue : **Central Lecture Theatre, IIT Madras**



**CoSMIC**  
**IOWA STATE**  
**UNIVERSITY**

Sponsored by

**AMETEK** Instruments India Pvt. Ltd.

## Atom Probe Tomography

Atom Probe Tomography (APT or 3DAP for Three-dimensional Atom Probe) is the only material analysis technique offering extensive capabilities for both **3D imaging** and **chemical composition measurements at the atomic scale**. Since its early developments, 3D Atom Probe has contributed to major advances in materials science. Some applications of the Atom Probe are listed below.

- Quantitative atomic scale 3D elemental mapping of chemical species in materials
- 3D analysis of precipitation strengthening in various alloys
- Interface composition analysis, grain boundary composition analysis
- Segregation analysis on atomic scale
- Diffusion studies
- Dopant distributions in semiconductors

## Who should participate?

The workshop is aimed to provide fundamentals as well as advanced knowledge of the Atom Probe Tomography and its applications. The current understanding and status of elemental analysis and high resolution imaging in TEM will also be discussed. Research scholars in academic institutions and R&D laboratories working in the area of materials science and engineering are eligible to participate in this workshop.

## List of Speakers

- Prof. S. Ranganathan, IISc, Bangalore
- Prof. Krishna Rajan, Iowa State University, USA
- Peter Clifton, CAMECA, France
- Prof. K. Chattopadhyay, IISc, Bangalore
- Dr. M. Vijayalakshmi, IGCAR, Kalpakkam
- Dr. G. K. Dey, BARC, Mumbai
- Dr. R Balamuralikrishnan, DMRL, Hyderabad
- Dr. R. Gopalan, ARCI, Hyderabad
- Dr. Chandan Srivastava, IISc, Bangalore
- Dr. Anirudha Biswas, BARC, Mumbai
- Prof. B. S. Murty, IIT Madras

## Few Points

- *There is no registration fee*
- *Last date for registration: **Dec. 20, 2011***
- *Limited accommodation available on request*